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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,465	DUPUIS ET AL.	
Examiner	Art Unit	_
Nam Huynh	2643	

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Class	Subclass	Date	Examiner
455	410	1/17/2005	NTH
	411		
	418		
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	435.1		
	414.1		
340	5.1	1/17/2005	NTH
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See EAST search notes.	1/17/2005	NTH